

## Notice of References Cited

Application/Control No.
10/053,754

Examiner

David Purol

Applicant(s)/Patent Under Reexam
Steven Dunn et al.

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<sup>\*</sup> A copy of this reference is not being furnished with this Office action. See MPEP \$ 707.05(a).

<sup>&</sup>lt;sup>1</sup> Dates in MM-YYYY format are publication dates.

 $<sup>^{\</sup>rm 2}$  Classifications may be U.S. or foreign.